## <u>MOSFET</u> – Power, N-Channel

## 60 V, 98 A, 5.7 m $\Omega$

#### Features

- Low R<sub>DS(on)</sub>
- High Current Capability
- 100% Avalanche Tested
- These Devices are Pb-Free, Halogen Free and are RoHS Compliant

#### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Param	Symbol	Value	Unit		
Drain-to-Source Voltage			V <sub>DSS</sub>	60	V
Gate-to-Source Voltage	ə – Contir	nuous	V <sub>GS</sub>	±20	V
Gate–to–Source Voltage – Non–Repetitive (t <sub>p</sub> < 10 μs)			V <sub>GS</sub>	±30	V
Continuous Drain		$T_C = 25^{\circ}C$	Ι <sub>D</sub>	98	А
Current (R <sub>θJC</sub> ) (Note 1)	Steady State	$T_C = 100^{\circ}C$		69	
Power Dissipation ( $R_{\theta JC}$ )	Slale	$T_C = 25^{\circ}C$	PD	115	W
Pulsed Drain Current	t <sub>p</sub> :	= 10 μs	I <sub>DM</sub>	335	А
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	–55 to 175	°C
Source Current (Body Diode)			۱ <sub>S</sub>	96	А
Single Pulse Drain-to-Source Avalanche Energy (L = 0.3 mH)			E <sub>AS</sub>	205	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	1.3	°C/W
Junction-to-Ambient - Steady State (Note 2)	R <sub>0.IA</sub>	37	

1. Limited by package to 50 A continuous.

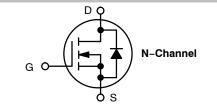
2. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces.

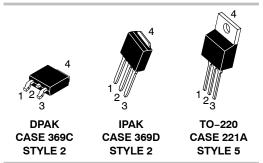


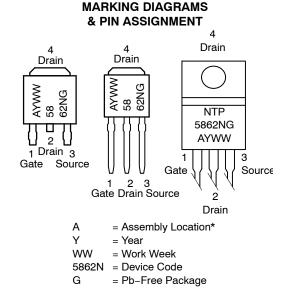
## **ON Semiconductor®**

#### www.onsemi.com

V <sub>(BR)DSS</sub> R <sub>DS(on)</sub> MAX		I <sub>D</sub> MAX	
60 V	5.7 mΩ @ 10 V	98 A	







\* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 5 of this data sheet.

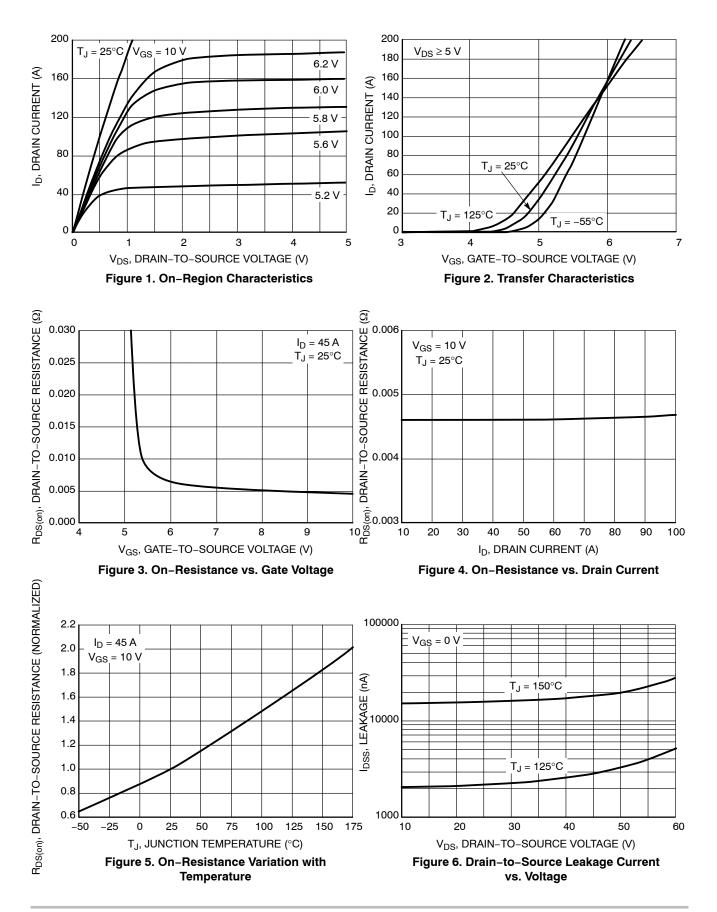
## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•I						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_D$ = 250 $\mu$ A		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				47		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$			1.0	μΑ
		V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 60 V	$T_J = 150^{\circ}C$			100	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS}$	<sub>S</sub> = ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= 250 μA	2.0		4.0	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-9.7		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>I</sub>	<sub>0</sub> = 45 A		4.4	5.7	mΩ
Forward Transconductance	gFS	V <sub>DS</sub> = 15 V, I <sub>[</sub>	<sub>)</sub> = 10 A		18		S
CHARGES, CAPACITANCES AND GA	TE RESISTANCE	S					
Input Capacitance	C <sub>iss</sub>				5050	6000	pF
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 25 V			500	600	1
Reverse Transfer Capacitance	C <sub>rss</sub>	•03 - 24			300	420	
Total Gate Charge	Q <sub>G(TOT)</sub>				82		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 48 V, I <sub>D</sub> = 45 A			5.2		
Gate-to-Source Charge	Q <sub>GS</sub>				24		
Gate-to-Drain Charge	Q <sub>GD</sub>				27		
Gate Resistance	R <sub>G</sub>				0.6		Ω
SWITCHING CHARACTERISTICS (Not	e 4)						
Turn-On Delay Time	t <sub>d(on)</sub>				18		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>D</sub>	<sub>D</sub> = 48 V,		70		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D = 45 \text{ A}, \text{ R}_G$	= 2.5 Ω		35		
Fall Time	t <sub>f</sub>				60		
DRAIN-SOURCE DIODE CHARACTER	RISTICS				•		•
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$		0.9	1.2	V
		$I_{\rm S} = 45 \text{ A}$ $T_{\rm J} = 100^{\circ}\text{C}$			0.75		1
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dls/dt = 100 A/μs, I <sub>S</sub> = 45 A			38		ns
Charge Time	ta				20		1
Discharge Time	tb				18		1
Reverse Recovery Charge	Q <sub>RR</sub>				40		nC

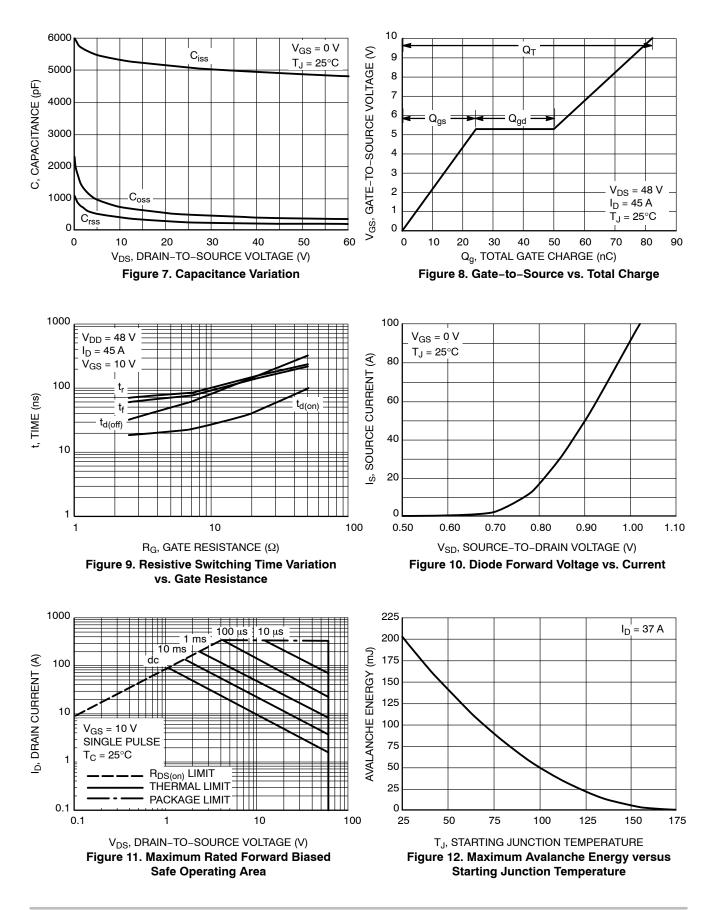
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 3. Pulse Test: Pulse Width  $\leq$  300 µs, Duty Cycle  $\leq$  2%.

4. Switching characteristics are independent of operating junction temperatures.

### **TYPICAL CHARACTERISTICS**



### **TYPICAL CHARACTERISTICS**



## **TYPICAL CHARACTERISTICS**

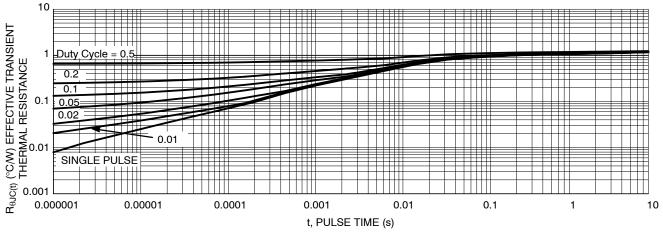


Figure 13. Thermal Response

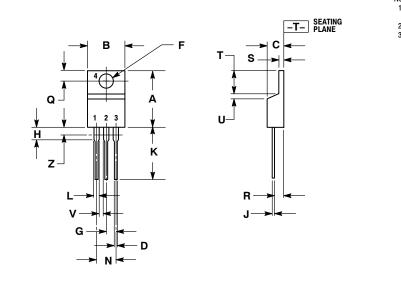
#### **ORDERING INFORMATION**

Order Number	Package	Shipping <sup>†</sup>
NTD5862N-1G	IPAK (Straight Lead) (Pb-Free)	75 Units / Rail
NTD5862NT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NTP5862NG	TO-220 (Pb-Free)	50 Units / Rail

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

TO-220 CASE 221A-09 **ISSUE AH** 



NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH. 3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED. MILLIMETERS INCHES DIM MIN MAX MIN MAX A B 
 0.570
 0.620
 14.48
 15.75

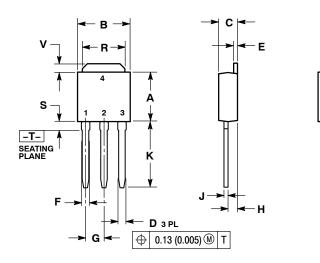
 0.380
 0.415
 9.66
 10.53
 CD 0.160 0.190 4.07 4.83 0.025 0.038 0.64 0.96 
 F
 0.142
 0.161
 3.61

 G
 0.095
 0.105
 2.42
 4.09 2.66 H 0.110 0.161 2.80 4.10 J 0.014 0.024 0.36 0.61 κ 0.500 0.562 12.70 14.27 0.045 0.060 1.15 1.52 L Ν 0.190 0.210 4.83 2.54 5.33 Q 0.100 0.120 3.04 2.79 1.39 2.04 R 0.110 0.080 S 0.045 0.055 1.15 
 T
 0.235
 0.255
 5.97

 U
 0.000
 0.050
 0.00

 V
 0.045
 --- 1.15
 6.47 1.27 Z 0.080 2.04 STYLE 5: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

**IPAK** CASE 369D **ISSUE C** 





z

NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.35	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
Е	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.090	) BSC	2.29 BSC		
н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
Κ	0.350	0.380	8.89	9.65	
R	0.180	0.215	4.45	5.45	
S	0.025	0.040	0.63	1.01	
V	0.035	0.050	0.89	1.27	
Z	0.155		3.93		

STYLE 2: PIN 1. GATE 2. DRAIN

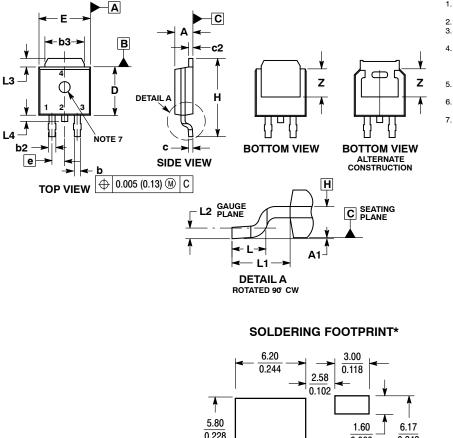
З. SOURCE

4. DRAIN

#### PACKAGE DIMENSIONS

**DPAK (SINGLE GAUGE)** CASE 369C

ISSUE E



NOTES

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
  DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL
- NOT EXCEED 0.006 INCHES PER SIDE. 5. DIMENSIONS D AND E ARE DETERMINED AT THE
- OUTERMOST EXTREMES OF THE PLASTIC BODY. 6. DATUMS A AND B ARE DETERMINED AT DATUM
- PLANE H. OPTIONAL MOLD FEATURE

OPTIONAL MOLD FEATURE.					
	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.028	0.045	0.72	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
E	0.250	0.265	6.35	6.73	
е	0.090	BSC	2.29 BSC		
н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.114 REF		2.90 REF		
L2	0.020 BSC		0.51 BSC		
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0.155		3.93		

STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE

4. DRAIN

0.228 0.063 0.243  $\left(\frac{\text{mm}}{\text{inches}}\right)$ SCALE 3:1

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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